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May 2024



FAN4149 Ground Fault Interrupter

Features

- Meets 2015 UL943 Self-Test Requirements (in combination with FAN41501)
- Precision Sense Amplifier and Bandgap Reference
- Low-Vos Offset for Direct DC Coupling of Sense Coil
- Built-in Noise Filter
- High-Current SCR Gate Driver
- Adjustable Sensitivity
- 500 μA Quiescent Current
- Minimum External Components
- Ideal for 120 V or 220 V Syst ins
- Space-Saving, SOT2 Pin hckage

Application

- GFCI Out, * *acie
- CECLU ruit Pres' irs
- Port. 'e CI Cords
- Resid al-Current Devices (RCD)

Description

The FAN4149 is a lo power co roll for detecting hazardous current participite group and ground-toneutral faults. The AN- 19 an lication circuit opens the load content to beful a multiplication cours.

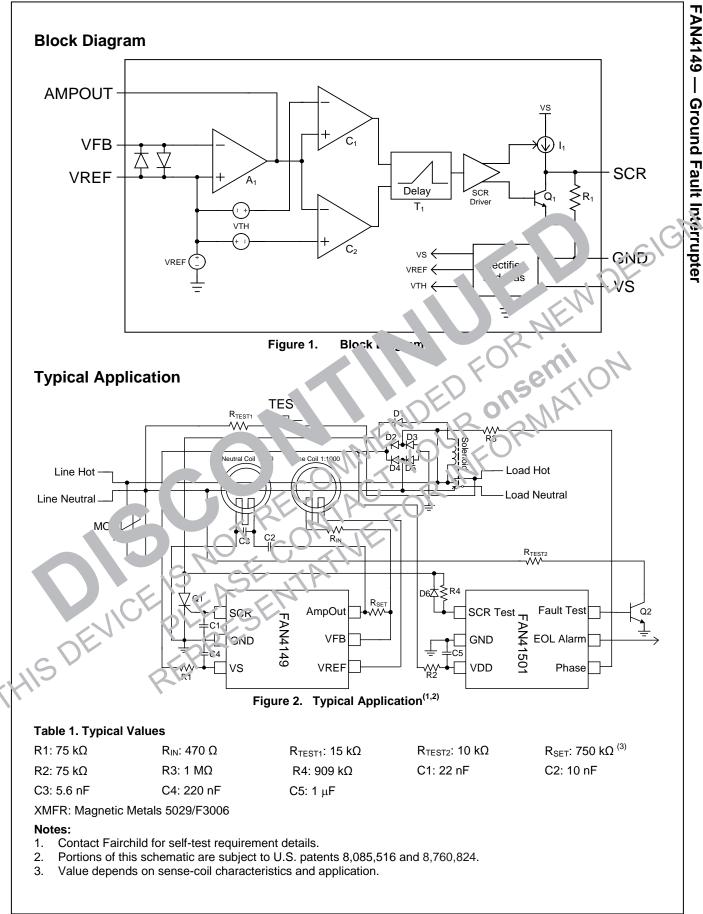
The FAN4 19, com' nation with the FAN41501 automolectical characteristic connected GFCI st qual this for permanently connected GFCI p fluc. The FAN4 49 detects a lo protects against a houring or ground fault and a neutral-to-line/load short. The AN41501 periodically monitors the FAN4149 and critical Girl components to comply with the 2015 UL943 requirements. The minimum number of components and the small 6-pin package plow for a dense, flexible, application solution.

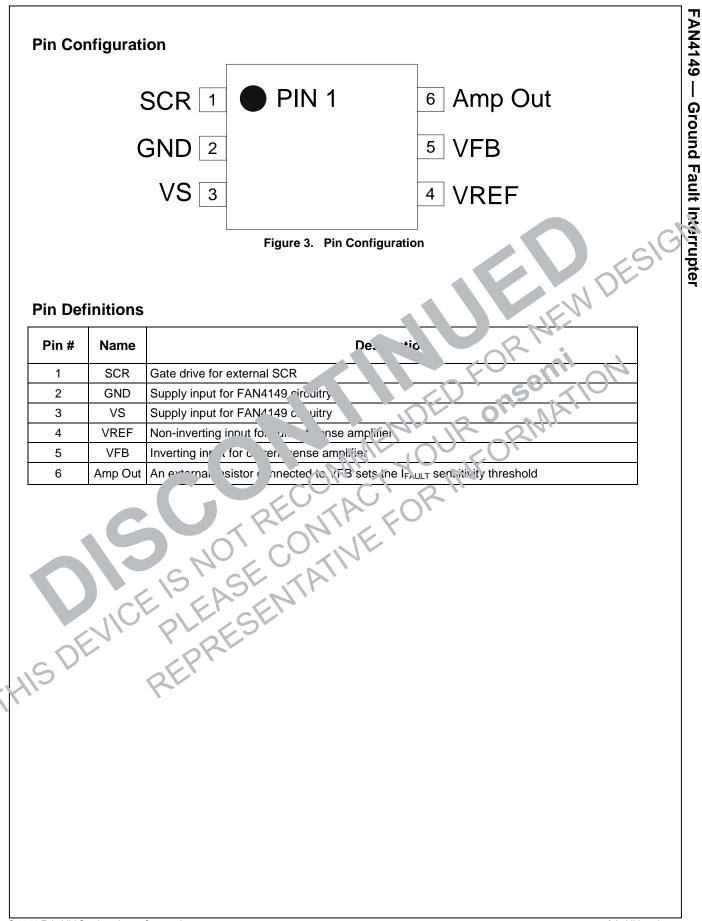
The FAN4149 contains a precision bandgap 14 V shunt regulator, precision low-Vos sense amplifier, time-delay noise filter, window-detection comparators, and an SCR driver. The shunt regulator operates with a low quescent current, which allows for a high value, lowwattage series supply resistor. The internal temperature compensated shunt regulator, sense amplifier, and bias circuitry provide for precision ground-fault detection. This enables the use of larger component variations so that binning or trimming external components is not required. The typical ±50 µV V_{OS} sense amplifier offset allows for direct DC coupling of the sense coil. This eliminates the large AC-coupling capacitor. The internal delay filter rejects high-frequency noise spikes common with inductive loads. This decreases false nuisance tripping. The SCR driver provides increased current and temperature compensation to allow for a wider selection of external SCRs.

The minimum number of external components and the 6-pin SOT23 package allow a low-cost, compact design and layout.

Ordering Information

Part Number	Operating Temperature Range	Package	Packing Method
FAN4149M6X	-35°C to +85°C	6-Lead, SOT23, JEDEC M0-178, 1.6 mm	Tape and Reel





FAN4149 — Ground Fault Interrupter

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Condition	Min.	Max.	Unit
I _{CC}	Supply Current	Continuous Current, VS to GND		15	mA
V _{cc}	Supply Voltage	Continuous Voltage to GND, All Pins	-0.8	16.0	V
T _{STG}	Storage Temperature Range		-65	+150	°C
ESD	Electrostatic Discharge Capability	Human Body Model, ANSI/ESDA/JEDEC JS-001-2012		2.5	kV 💊
		Charged Device Model, JESD22-C ⁺ 1		.0	ŻŚ
			NE	NC	
DC Elec	trical Characteristics	R			
Unless oth	erwise specified, T _A =25°C, I _{shunt} =1 mA	A, and r Grence g.F. Ire 2.	n		7

DC Electrical Characteristics

Symbol	Parameter	Cor. Jitions	<u>۳.</u> ".n.	тур.	Max.	Unit
V _{REG}	Power Supply Shunt Regulato. Voltage	Tt. AND	i3.7	14.0	14.3	V
Ι _Q	Quiescent Current	ne to GNԴ₌ 10 V	425	500	575	μA
V_{REF}	Reference Volters	VREF TO GND	6.85	7.00	7.15	V
V _{TH}	Trip Thresh J	A np Out to VI?EF	4.35	4.50	4.65	V
Vos	Amr' Ofi t	Cain=1000	-175	±50	175	μV
		Gain= 1000	-100		100	μV
los	mplifier Ir ut Offset(Design Value	-50	0	50	nA
G	A. Iifier DC Gain ^(c)	Design Value		100		dB
BW	Amplifier Gair, Bandwi Sth ⁽⁵⁾	Design Value		3		MHz
V.	Amplifier Positive Voltage Swing	Amp Out to VREF, I _{FAULT} =10 μA	5.5			V
V _{SW-}	Amplifier Negative Voltage Swing	VREF to Amp Out, I _{FAULT} =-10 µA	5.5			V
ISINK	Amplifier Current Sink	Amp Out=V _{REF} + 3 V V _{FB} =V _{REF} + 100 mV	400			μA
SRL	Amplifier Current Source	Amp Out=V _{REF} – 3 V,V _{FB} =V _{REF} -100 mV	400			μA
t _d	Delay Filter	Delay from C ₁ Trip to SCR L->H	0.65	1.00	1.35	ms
Rout	SCR Output Resistance	SCR to GND=250 mV, Amp Out=V _{REF}		0.5	1.0	kΩ
V _{OUT}	SCR Output Voltage	SCR to GND, Amp Out=V _{REF}		1	10	mV
	SCR Output Voltage	SCR to GND, AMP Out=V _{REF} +4 V	3.0			V
I _{OUT}	SCR Output Current	SCR to GND=1 V Amp Out= V_{REF} + 4 V, I _{SHUNT} =2 mA	650	725		μA

Notes:

Maximum V_{OS} offset temperature cycling drift from initial value (JEDEC JESD22-A104). 4.

Guaranteed by design, not tested in production. 5.

Functional Description

Refer to Figure 2.

The FAN4149 is a GFCI controller for AC ground-fault circuit interrupters. The low- V_{OS} offset for the sense amplifier allows for direct DC coupling of the sense coil when the FAN4149 is biased with a full-wave diode bridge. This allows for the FAN4149 to be used with the FAN41501 digital auto-monitoring controller to provide for a low-BOM-cost, complete, GFI solution with self testing for the critical GFCI components.

The internal shunt regulator rectifier circuit is supplied from the full-wave rectifier bridge and 75 k Ω series resistor. A typical 220 nF V_S bypass capacitor is used to filter the V_{AC} ripple voltage. The internal 14 V shunt regulator uses a precision temperature-compensated bandgap reference. The combination of precision reference circuitry and precision sense amplifier provides for an accurate ground-fault tolerance. This allows for selection of external components with wider and lower-cost parameter variations. Due to the low quiescent current, a high-value external series resistor (R_1) can be used to reduce the maximum power wattage required for this resistor. The 14 V shunt regulat generates the V_{REF} reference voltage for the slise amplifier's (A1) non-inverting input (AC round reference). It also supplies the bias for the delay mer (t_1) , comparators (C₁ & C₂), and the SCR dr.

The secondary winding of the anse one ormer is connected to pin 4 (VREF) and t a resist , Riv, which is directly DC connecter he verting input of the sense amplifier at pin (VFB). The uback resistor (R_{SET}) converts the sinse tr sformer's secondary current to a voluge at pl C (A p Out). This voltage is compared to t 'window comparator ($C_1 \in C_2$). When the np out vol ge exceeds the $\pm V_{1H}$ threshold volt the vin. companyios triggers the internal ay tin. 1. output of the window comparator must su HIGF or the duration of the sufficient. If the window con are soutput goes LOVV the internal delay timer starts reset cicle. If the window comparator's output is still HIGH at the end of the t1 pulse, the SCR driver enables surrent source i_1 and discoles Q1. Current source l_1 then enables the external SCR; which energizes the solenoid, coens the contact switches to the load, and removes the hazardous ground fault. The window comparator allows for detection of a positive or negative I_{FAULT} signal, independent from the phase of the line voltage.

Calculation of R_{SET} Resistor

The Amp Out signal must exceed the window comparator's V_{TH} threshold voltage for longer than the delay timer and calculated by:

 $V_{TH} = I_{FAULT} \times 1.22 \times R_{SET} \times COS(2\pi \times (t/2P)) / N$ (1)

 $R_{SET} = (V_{TH} \times N) / (1.22 \times I_{FAULT} \times COS(\pi \times t/P))$ (2)

where:

V_{TH} = 4.5 V

 $I_{FAULT} = 5 \text{ mA}_{RMS} (UL943)$

- T = 1 ms (timer delay)
- P = Period of the AC Line (1/60 Hz)
- P = Period of the AC Line (1/60 Hz)
- N= Ratio of secondary-to-primary turns (1000:1)

 R_{SET} = 750 k Ω (standard 1% value)

In practice, the transformer is non-ideal, so R_{SET} may need to be adjusted by up to 30% to obtain the desired I_{FAULT} trip threshold.

Calculation of Vos Trip Threebold Error

Since the sense coil is dir by co. acted to the feedback of the sense time ar, the V_{OS} of set introduces an I_{FAULT} the sense time are the error can be calculated as follow:

%Error =1. x (V_{OL} R_{SL} $(R_{IN} + R_{LDC}) / V_{TH}$ (3)

The $V_{OS} \pm 160 \,\mu$ V maximum drift specification is based on temperature cycling per JEDEC JESD22-A104, Condition B, 850 temperature cycles at -55°C to +125°C.

Grounded Neutral Detection

If the neutral load terminal side is incorrectly connected to the earth ground, the sense coil does not correctly detect the hazardous ground fault current from "load hot" to earth ground due to the partial I_{FAULT} current flowing from the grounded neutral fault (load neutral) to earth ground.

To detect a grounded neutral fault, a grounded neutral coil is required. When a low resistive path occurs from the line neutral and load neutral terminals, the sense and neutral coils are mutually coupled. The mutual coupling produces a positive feedback path around the sense amplifier, which causes the sense amplifier to oscillate. When the peak oscillation voltage exceeds the SCR trigger threshold, the internal delay timer is enabled. Since the amplifier's output signal is crossing the window comparator's trip threshold typically at 6 kHz, the delay timer alternates between detection of a fault/no-fault. The ratio of the fault/no-fault detection time interval determines if the SCR driver is enabled.

The sensitivity of the grounded neutral detection can be changed by the neutral coil turns and the value of C_2 and $C_3. \label{eq:constraint}$

GFCI Self Test Requirement

Starting in June of 2015, UL943 requires all permanently connected GFCI products to perform a self-test function. By adding Fairchild's FAN41501 product to the FAN4149 application (see Figure 2), a fully compliant 2015 UL943 self-test function can be achieved with two, small, independent, 6-pin, 1.6 mmwide devices and a minimum number of external components. The 2015 UL code requires that, at power up, the GFCI self test the critical GFCI components --

FAN4149, SCR, sense coil, and solenoid -- within five seconds and thereafter within every three hours. The self-test cycle cannot open the load contacts. If a component failure is detected, the load power must be denied. Refer to the FAN41501 datasheet for more details about the UL943 self-test features.

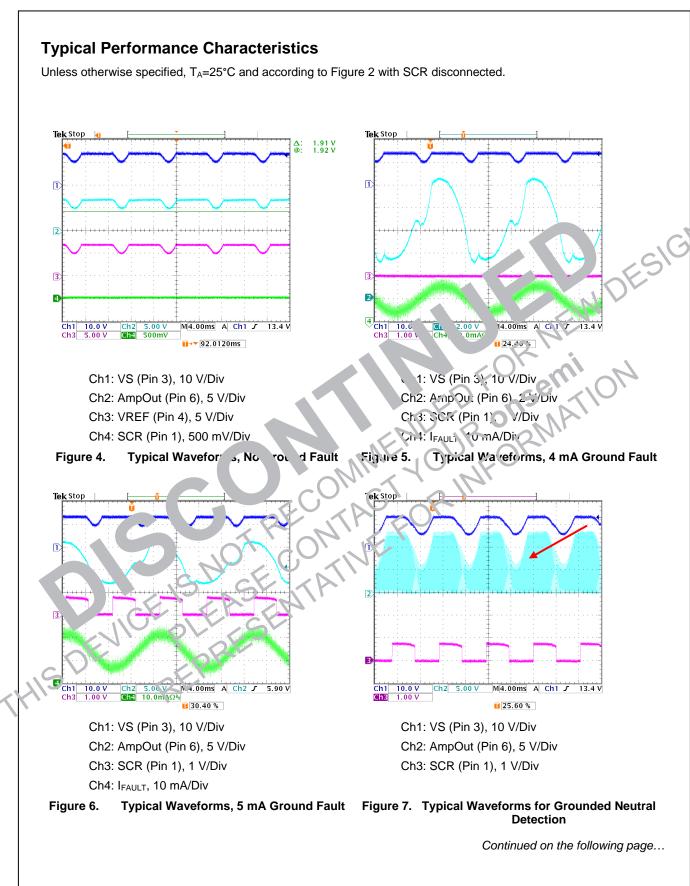
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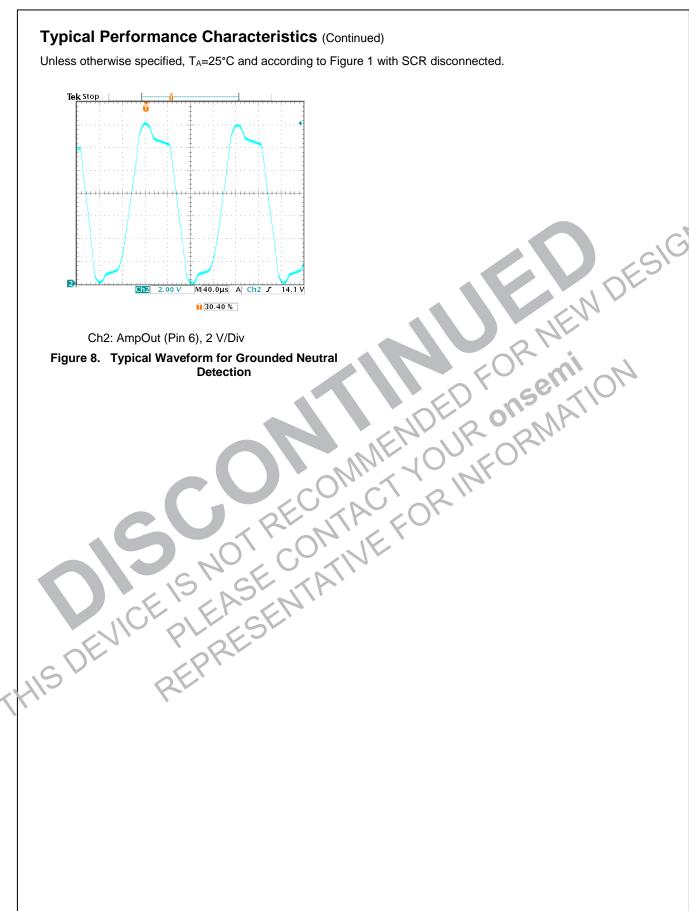
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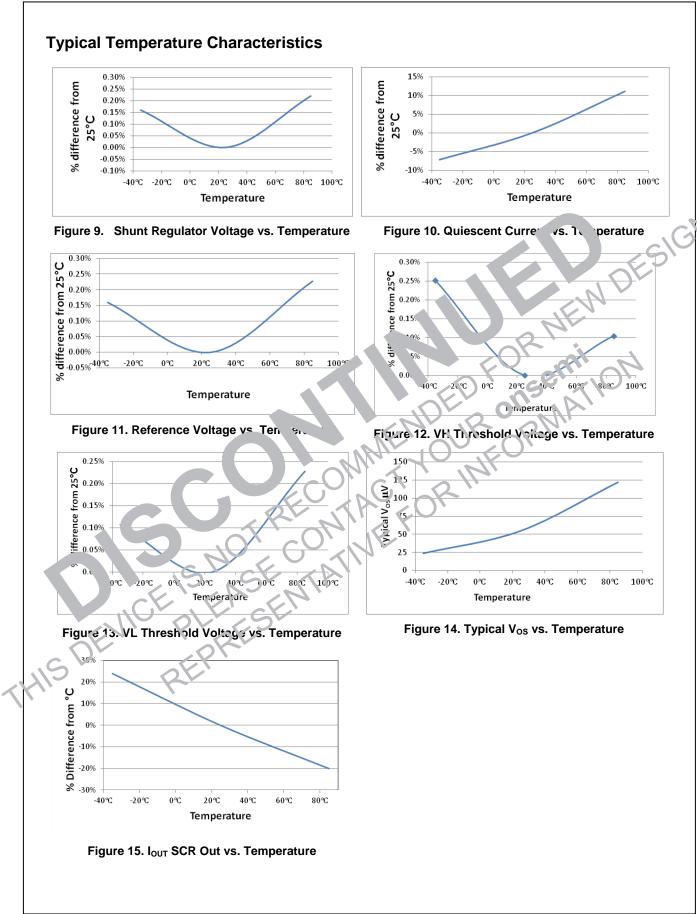
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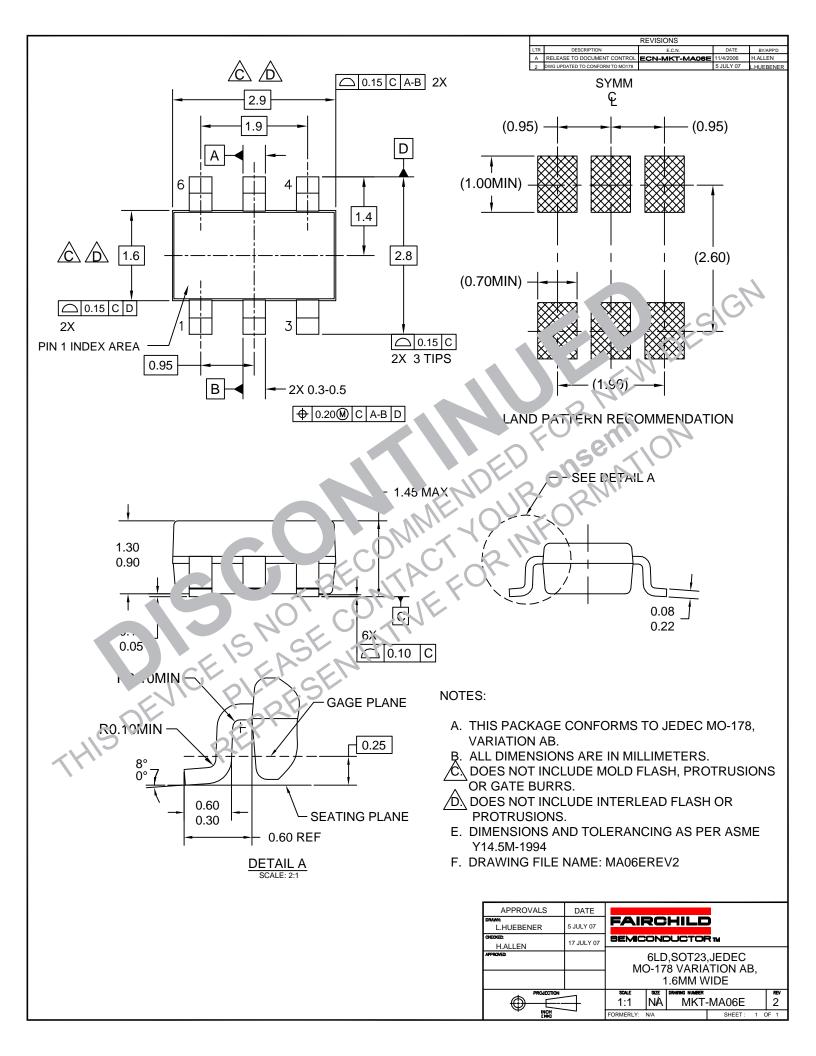








FAN4149 — Ground Fault Interrupter



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